CMOS Digital Integrated Circuits Silicon Monolithic

74LCX573FT

1. Functional Description

Low-Voltage Octal D-Type Latch with 5-V Tolerant Inputs and Outputs

2. General

The 74LCX573FT is a high-performance CMOS octal D-type latch. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) V_{CC} applications, but it could be used to interface to 5-V supply environment for both inputs and outputs.

This 8-bit D-type latch is controlled by a latch enable input (LE) and an output enable input ($\overline{\text{OE}}$).

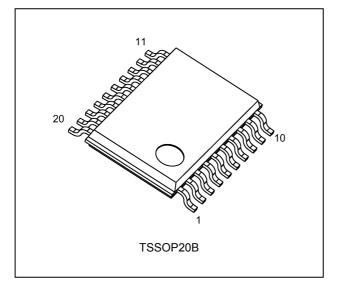
When the $\overline{\text{OE}}$ input is high, the eight outputs are in a high-impedance state.

All inputs are equipped with protection circuits against static discharge.

3. Features

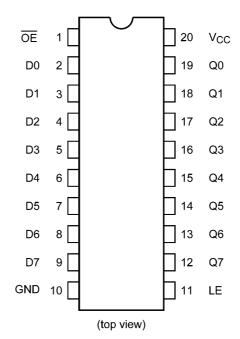
- (1) Low-voltage operation: V_{CC} = 1.65 to 3.6 V
- (2) High-speed operation: $t_{pd} = 8.0 \text{ ns} \text{ (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$
- (3) Output current: $|I_{OH}|/I_{OL} = 24$ mA (min) (V_{CC} = 3.0 to 3.6 V)
- (4) Power-down protection provided on all inputs and outputs
- (5) Pin and function compatible with the 74 series (74LVC/ALVC/ etc.) 573 type

4. Packaging

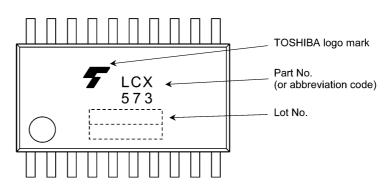


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6. Marking



7. IEC Logic Symbol

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8. Truth Table

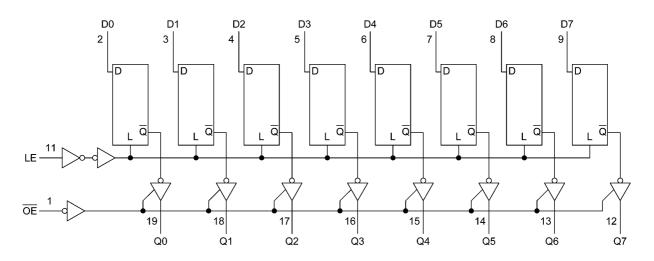
Inputs OE	Inputs LE	Inputs D	Outputs
Н	х	х	Z
L	L	х	Qn
L	Н	L	L
L	Н	Н	Н

X: Don't care

Z: High impedance

Qn: Q outputs are latched at the time when the LE input is taken to a low logic level.

9. System Diagram



10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V _{CC}		-0.5 to 6.5	V
Input voltage	V _{IN}		-0.5 to 6.5	V
Output voltage	V _{OUT}	(Note 1)	-0.5 to 6.5	V
		(Note 2)	-0.5 to V _{CC} + 0.5	
Input diode current	I _{IK}		-50	mA
Output diode current	I _{OK}	(Note 3)	±50	mA
Output current	I _{OUT}		±50	mA
Power dissipation	PD		180	mW
V _{CC} /ground current	I _{CC} /I _{GND}		±100	mA
Storage temperature	T _{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Output in OFF state.

Note 2: High (H) or Low (L) state. I_{OUT} absolute maximum rating must be observed.

Note 3: V_{OUT} < GND, V_{OUT} > V_{CC}

11. Operating Ranges (Note)

Characteristics	Symbol Note Rating		Unit	
Supply voltage	V _{CC} 1.65 to		1.65 to 3.6	V
		(Note 1)	1.5 to 3.6	
Input voltage	V _{IN}		0 to 5.5	V
Output voltage	V _{OUT}	(Note 2)	0 to 5.5	V
		(Note 3)	0 to V _{CC}	
Output current	I _{OH} ,I _{OL}	(Note 4)	±24	mA
	I _{OH} ,I _{OL}	(Note 5)	±12	
Operating temperature	T _{opr}		-40 to 85	°C
Input rise and fall times	dt/dv	(Note 6)	0 to 10	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.

Note 1: Data retention only.

Note 2: Output in OFF state.

Note 3: High or low state

Note 4: V_{CC} = 3.0 to 3.6 V

Note 5: V_{CC} = 2.7 to 3.0 V

Note 6: $V_{\rm IN}$ =0.8 to 2.0 V , $V_{\rm CC}$ = 3.0 V

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12. Electrical Characteristics

12.1. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
High-level input voltage	V _{IH}	—		1.65 to 2.3	$V_{CC} \times 0.9$	—	V
				2.3 to 2.7	1.7	_	
				2.7 to 3.6	2.0	—	
Low-level input voltage	V _{IL}	—		1.65 to 2.3		$V_{CC} \times 0.1$	
				2.3 to 2.7		0.7	
				2.7 to 3.6	_	0.8	
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.65 to 3.6	V _{CC} - 0.2	_	V
			I _{OH} = -4 mA	1.65	1.05	_	
			I _{OH} = -8 mA	2.3	1.7		
			I _{OH} = -12 mA	2.7	2.2	_	
			I _{OH} = -18 mA	3.0	2.4	_	
			I _{OH} = -24 mA	3.0	2.2		
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.65 to 3.6		0.2	
			I _{OL} = 4 mA	1.65		0.45	
			I _{OL} = 8 mA	2.3	_	0.7	
			I _{OL} = 12 mA	2.7		0.4	
			I _{OL} = 16 mA	3.0		0.4	
			I _{OL} = 24 mA	3.0		0.55	
Input leakage current	I _{IN}	V _{IN} = 0 to 5.5 V		1.65 to 3.6		±5.0	μA
3-state output OFF-state leakage current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 5.5 V		1.65 to 3.6		±5.0	μA
Power-OFF leakage current	I _{OFF}	V_{IN}/V_{OUT} = 5.5 V		0	—	10.0	μA
Quiescent supply current	I _{CC}	$V_{IN} = V_{CC}$ or GND		1.65 to 3.6		10.0	μA
		V_{IN}/V_{OUT} = 3.6 to 5.5 V		1.65 to 3.6	—	±10.0	
Quiescent supply current	Δl _{CC}	V _{IH} = V _{CC} - 0.6 V (per input)		2.7 to 3.6	_	500	

12.2. AC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Note	Test Condition	V_{CC} (V)	Min	Max	Unit
Propagation delay time (D-Q)	t _{PLH} ,t _{PHL}		See 12.5 AC Test Circuit,	1.8 ± 0.15		30.0	ns
			Table 12.5.1, Fig. 12.6.1, Table 12.6.1	2.5 ± 0.2	_	10.0	
				2.7	_	9.0	
				3.3 ± 0.3	1.5	8.0	
Propagation delay time (LE-Q)	t _{PLH} ,t _{PHL}		See 12.5 AC Test Circuit,	1.8 ± 0.15	_	30.0	ns
			Table 12.5.1, Fig. 12.6.1, Table 12.6.1	2.5 ± 0.2	_	10.5	
				2.7		9.5	
				$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.5	
Output enable time	t _{PZL} ,t _{PZH}		See 12.5 AC Test Circuit,	1.8 ± 0.15	_	34.0	ns
			Table 12.5.1, Fig. 12.6.2,	2.5 ± 0.2		17.0	
			Table 12.6.1	2.7	_	9.5	
				$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.5	
Output disable time	t _{PLZ} ,t _{PHZ}		See 12.5 AC Test Circuit, Table 12.5.1, Fig. 12.6.2, Table 12.6.1	1.8 ± 0.15		28.0	ns
				2.5 ± 0.2		14.0	
			2.7	_	7.0		
				$\textbf{3.3}\pm\textbf{0.3}$	1.5	6.5	
Minimum pulse width (LE)	t _{w(H)}	Table 12.5.1, Fig. 12.6.1,	1.8 ± 0.15	10.0	_	ns	
			2.5 ± 0.2	5.0	_		
			Table 12.6.1	2.7	3.3		
				$\textbf{3.3}\pm\textbf{0.3}$	3.3	—	
Minimum setup time	t _S		See 12.5 AC Test Circuit, Table 12.5.1, Fig. 12.6.1,	1.8 ± 0.15	10.0	_	ns
				2.5 ± 0.2	5.0	_	
			Table 12.6.1	2.7	2.5	_	
				$\textbf{3.3}\pm\textbf{0.3}$	2.5		
Minimum hold time	t _h		See 12.5 AC Test Circuit,	1.8 ± 0.15	1.5	_	ns
			Table 12.5.1, Fig. 12.6.1, Table 12.6.1	2.5 ± 0.2	1.5	_	
			1 AUIC 12.0.1	2.7	1.5	_	
				$\textbf{3.3}\pm\textbf{0.3}$	1.5	_	
Output skew	t _{osLH} ,t _{osHL}	(Note 1)	_	2.7	_	_	ns
				$\textbf{3.3}\pm\textbf{0.3}$	_	1.0	

Note 1: Parameter guaranteed by design. ($t_{osLH} = |t_{PLHm} - t_{PLHn}|$, $t_{osHL} = |t_{PHLm} - t_{PHLn}|$)

12.3. Dynamic Switching Characteristics (Unless otherwise specified, $T_a = 25$ °C, Input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500$ Ω)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V_{OL}	V _{OLP}	V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	0.8	V
Quiet output minimum dynamic V_{OL}	V _{OLV}	V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	0.8	V

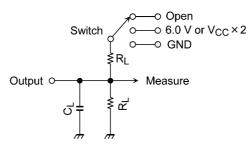
12.4. Capacitive Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}		_	3.3	7	pF
Output capacitance	C _{OUT}		_	3.3	8	pF
Power dissipation capacitance	C _{PD}	(Note 1)	f _{IN} = 10 MHz	3.3	25	pF

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation. $I_{CC}(opr) = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/8$ (per bit)

12.5. AC Test Circuit

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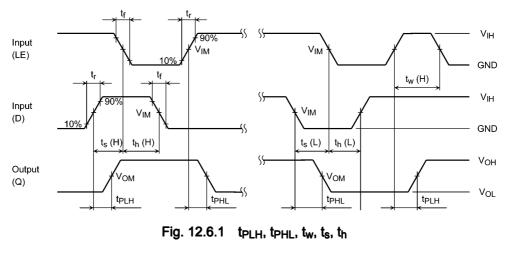


Parameter	Switch	Test Condition
t _{PLH} , t _{PHL}	OPEN	—
t _{PLZ} , t _{PZL}	6.0 V	V_{CC} = 3.3 \pm 0.3 V
		V _{CC} = 2.7 V
	$V_{CC} \times 2$	V_{CC} = 2.5 \pm 0.2 V
		V_{CC} = 1.8 \pm 0.15 V
t _{PHZ} , t _{PZH}	GND	_
t _w , t _s , t _h	OPEN	_

Table 12.5.1	Parameter for AC	Test Circuit
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12.6. AC Waveform



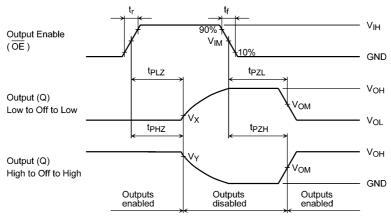


Fig. 12.6.2 t_{PLZ}, t_{PHZ}, t_{PZL}, t_{PZH}

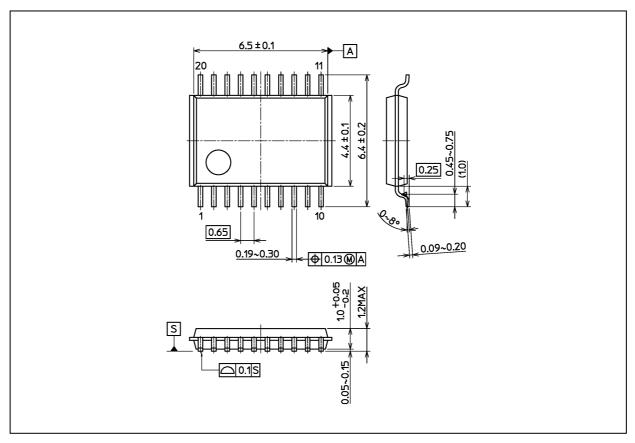
	Symbol	V_{CC} = 3.3 ± 0.3 V V_{CC} = 2.7 V	V_{CC} = 2.5 \pm 0.2 V	V_{CC} = 1.8 \pm 0.15 V
Input	V _{IH}	2.7 V	V _{CC}	V _{CC}
	V _{IM}	1.5 V	V _{CC} /2	V _{CC} /2
	t _r , t _f	2.5 ns	2.0 ns	2.0 ns
Output	V _{OM}	1.5 V	V _{OH} /2	V _{OH} /2
	V _X	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V
	V _Y	V _{OH} - 0.3 V	V _{OH} - 0.15 V	V _{OH} - 0.15 V
Load	CL	50 pF	30 pF	30 pF
	RL	500 Ω	500 Ω	1 kΩ

Table 12.6.1 AC Waveform Symbols



Package Dimensions

Unit: mm



Weight: 0.071 g (typ.)

	Package Name(s)
Nickname: TSSOP20B	

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